Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/826,918	MIYAZAWA ET AL.
Examiner	Art Unit
Anh T.N. Vo	2861

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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
347	86	11/17/2005	M		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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